



Certificate of Analysis

ULTRAGrade™ Solution
Palladium ICP / ICP-MS Standard
10000 µg/mL

Catalog Number: ICP-146
Lot Number: T00677
Lot Issue Date: 06/05/2014
Expiration Date: 07/31/2021

Starting Material: Palladium sponge (* *light sensitive*)
Starting Material Purity: 99.9995%, 99.9995%
Starting Material Lot #: BH02617, BH02976
Matrix: 2% nitric acid, 5% hydrochloric acid in low TOC water (< 50 ppb)
Atomic Weight Pd: 106.4

Certified Value: 10000 ± 20 µg/mL

This Certified Reference Material (CRM) was manufactured and verified in accordance with ULTRA's ISO 9001 registered quality system. The analyte concentration(s) were prepared and verified by an ISO Guide 34 / ISO 17025 accredited laboratory, and compared to calibration standards independently prepared using NIST SRM(s). The certified value and uncertainty value at the 95% confidence level for each analyte is determined gravimetrically.

Classical Wet Assay Method: Theoretical, based on gravimetric measurements

Confirmation by Inductively Coupled Plasma Spectroscopy (ICP / ICP/MS) vs. NIST SRM 3138

ULTRA uses purified acids, 18 megohm double deionized water, calibrated Class A glassware & meticulously cleaned bottles in the manufacturing of ULTRAGrade standards. Balances used in the manufacturing of this standard are calibrated with weights traceable to NIST in compliance with ANSI/NCSS Z-540-1 and ISO 9001.

Trace Metallic Impurities in Solution Standard in µg/mL:

* Al <0.005 ND	* Ga <0.005 ND	n Nb	n S
* Sb <0.005 ND	n Ge <0.005 ND	n Os	n Ta
* As <0.005 ND	* Au <0.005 D	s Pd	n Te
* Ba <0.005 ND	n Hf <0.005 ND	* P <0.005 ND	n Tl <0.005 ND
* Be <0.005 ND	n Ho <0.005 ND	* Pt <0.005 D	n Th
* Bi <0.005 ND	* In <0.005 ND	* K <0.005 ND	n Tm
* B <0.005 ND	n Ir <0.005 ND	n Pr	* Sn <0.005 ND
* Cd <0.005 ND	* Fe <0.005 ND	n Re	* Ti <0.005 ND
* Ca <0.005 ND	* La <0.005 ND	n Rh	n W
n Ce	* Pb <0.005 ND	n Rb	n U
n Cs	* Li <0.005 ND	n Ru	n V
* Cr <0.005 ND	n Lu <0.005 ND	n Sm	n Yb
* Co <0.005 ND	* Mg <0.005 ND	n Sc	n Y
* Cu <0.005 ND	* Mn <0.005 ND	* Se <0.005 ND	* Zn <0.005 ND
n Dy	* Hg <0.005 ND	* Si <0.005 ND	n Zr
* Er <0.005 ND	* Mo <0.005 ND	* Ag <0.005 ND	
* Eu <0.005 ND	n Nd <0.005 ND	* Na <0.005 ND	
* Gd <0.005 ND	* Ni <0.005 ND	* Sr <0.005 ND	

* - element checked for I - spectral interference n - not checked for
ND - not detected D - detected s - solution standard element

Density of Solution (measured at 20.00°C ± 0.05°C): 1.0300 g/mL



ISO 9001 Registered Quality System – TUV USA

William J. Leary
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